MOSFET - Power, Single

N-Channel 80 V, 20 mΩ, 30 A

Advance Information

NVTYS020N08HL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	80	V
Gate-to-Source Voltage	9		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	30	Α
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady	T _C = 100°C	1	21	
Power Dissipation	State	T _C = 25°C	P_{D}	42	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C	1	21	
Continuous Drain		T _A = 25°C	I _D	8.1	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady	T _A = 100°C		5.7	
Power Dissipation	State	T _A = 25°C	P _D	3.1	W
R _{θJA} (Notes 1, 3)		T _A = 100°C	1	1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C$, $t_p = 10 \mu s$		I _{DM}	122	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C	
Source Current (Body Diode)		IS	35	Α	
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.5 A)		E _{AS}	121	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	3.6	°C/W
Junction-to-Ambient - Steady State (Note 3)	R_{\thetaJA}	48	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

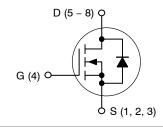


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	20 mΩ @ 10 V	30 A
00 V	26 mΩ @ 4.5 V	30 A

N-Channel





LFPAK8 3.3x3.3 CASE 760AD

MARKING DIAGRAM

XXXXXX XXXXXX AWLYW

XXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•		•		•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu A$		80			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		V _{DS} = 80 V	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 5)	•				•		•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 30 μΑ	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 5 A		16.5	20	mΩ
		V _{GS} = 4.5 V	I _D = 5 A		20.5	26	mΩ
Forward Transconductance	9FS	V _{DS} = 8 V, I _D	= 15 A		45		S
CHARGES, CAPACITANCES & GATE	RESISTANCE					•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 40 V			610		
Output Capacitance	C _{OSS}				83		pF
Reverse Transfer Capacitance	C _{RSS}				5		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 15 A			12		
Threshold Gate Charge	Q _{G(TH)}				1		nC
Gate-to-Source Charge	Q _{GS}				2		
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 40 \text{ V}; I_D = 15 \text{A}$			2		
Plateau Voltage	V_{GP}				3		V
Total Gate Charge	Q _{G(TOT)}				6		nC
SWITCHING CHARACTERISTICS (N	•				1	ı	L
Turn-On Delay Time	t _{d(ON)}				8		
Rise Time	t _r	Voe = 4.5 V. Vr	se = 64 V.		32		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{DS} = 64 V, I_{D} = 15 A, R_{G} = 2.5 Ω			14		ns
Fall Time	t _f				5		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				1	ı	
Forward Diode Voltage V	V_{SD}	V _{GS} = 0 V.	T _J = 25°C		0.80	1.2	
		$V_{GS} = 0 V$, $I_S = 5 A$	T _J = 125°C		0.66		V
Reverse Recovery Time	t _{RR}				29		
Charge Time	ta	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 15 A			18		ns
Discharge Time	t _b				11		1
Reverse Recovery Charge	Q _{RR}				21		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width $\leq 300~\mu$ s, duty cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

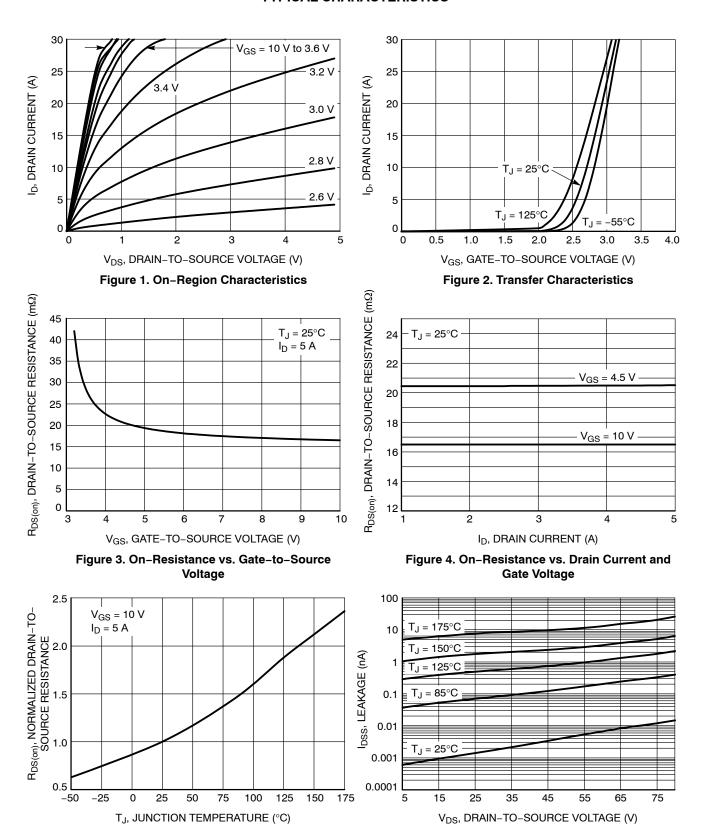


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS

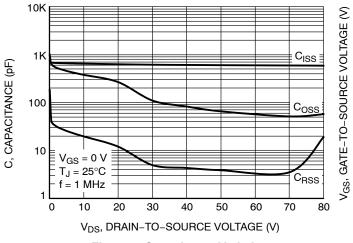


Figure 7. Capacitance Variation

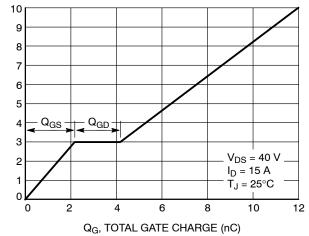
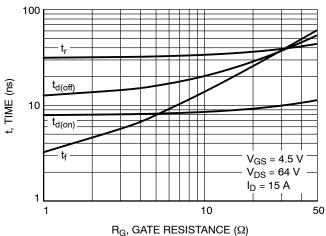


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



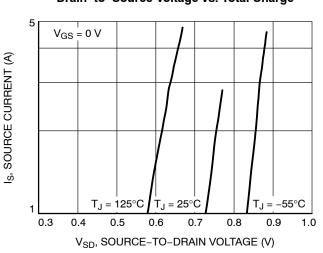


Figure 10. Diode Forward Voltage vs. Current



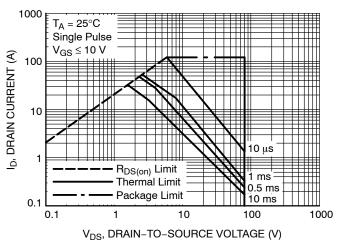


Figure 11. Safe Operating Area

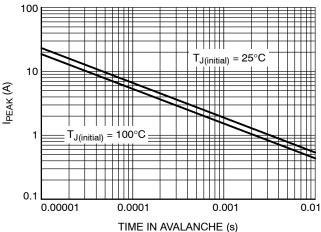


Figure 12. Maximum Drain Current vs. Time in **Avalanche**

TYPICAL CHARACTERISTICS

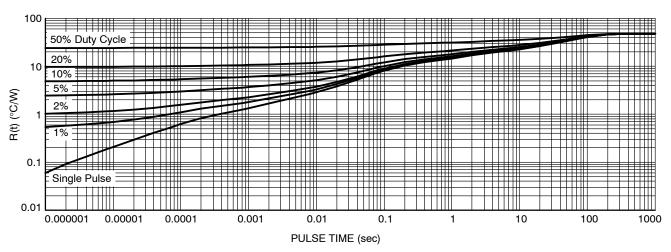


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

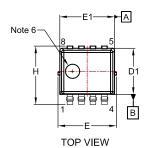
Device	Marking	Package	Shipping [†]
NVTYS020N08HLTAG	TBD	LFPAK8 (Pb-Free)	3000 / Tape & Reel

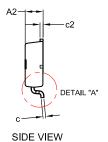
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

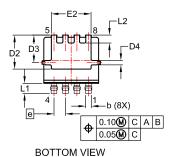
PACKAGE DIMENSIONS

LFPAK8 3.3x3.3, 0.65P

CASE 760AD ISSUE E



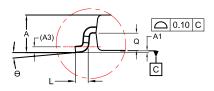




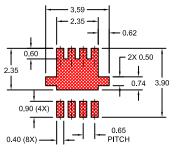
MIN. MAX. NOM. 0.95 1.05 1.15 Α 0.00 0.05 0.10 Α1 A2 0.95 1.00 1.05 0.15 REF АЗ 0.32 b 0.27 0.37 0.12 0.17 0.22 С 0.12 0.17 0.22 c2 D1 2.50 2.60 2.70 D2 1.82 1.92 2.02 D3 1.56 1.46 1.66 0.25 D4 0.20 0.30 F 3.20 3.30 3.40 E1 3.00 3.10 3.20 E2 2.15 2.25 2.35 0.65 BSC е Н 3.20 3.30 3.40 L 0.25 0.37 0.50 L1 0.48 0.58 0.68 L2 0.35 0.45 0.55 Q 0.45 0.50 0.55 θ 0° 4° 8°

MILLIMETERS

DIM



DETAIL 'A'



LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRIMO.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS OR BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 6. OPTIONAL MOLD FEATURE.

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